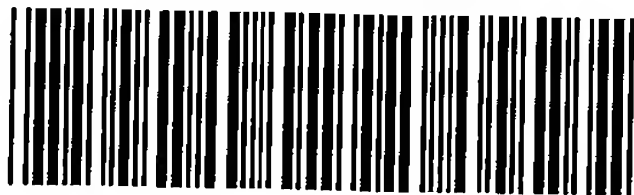


Search Notes



Application/Control No.

10/648,320

Examiner

Vivian Chen

Applicant(s)/Patent under Reexamination

TAKAHASHI ET AL.

Art Unit

1773

SEARCHED

Class	Subclass	Date	Examiner
		<i>See</i>	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
<i>Attachments</i>		

Application/Control Number: 10/648,320

Examiner: Vivian Chen

Art Unit: 1773

SEARCHED

Class	Subclass	Date	Exr
428	458, 35.7, 35.8, 35.9, 457, 480, 910, 331, 446, 447, 450	11/24/2004	vc
528	275, 283, 302, 305, 308, 308.1, 308.3, 308.6, 308.8		
524	275, 277, 261		
525	165, 437, 446		

Interference Searched

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